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September 2010

FDMC4435BZ

P-Channel Power Trench[®] MOSFET -30 V, -18 A, 20 m Ω

Features

- Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = -10 V, I_D = -8.5 A
- Max $r_{DS(on)}$ = 37 m Ω at V_{GS} = -4.5 V, I_D = -6.3 A
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- HBM ESD protection level >7 kV typical (Note 4)
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

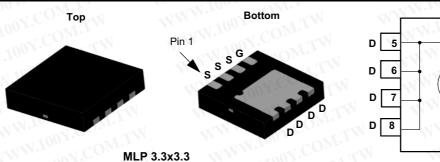
General Description

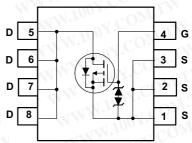
This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		W	Ratings	Units
V _{DS}	Drain to Source Voltage	W.Ino	OM.	-30	V
V _{GS}	Gate to Source Voltage	-1100Y.	OM.TW	±25	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C	COST	-18	OUX.
	-Continuous (Silicon limited)	T _C = 25 °C	CONL	-32	~~
ID	-Continuous	T _A = 25 °C	(Note 1a)	-8.5	00A.
	-Pulsed	WWW	Y.Co	-50	1007
E _{AS}	Single Pulse Avalanche Energy	TINN 100	(Note 3)	24	mJ
	Power Dissipation	Power Dissipation T _C = 25 °C		31	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	- VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange	est COI	-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	MMM.T. COA.COM	4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC4435BZ	FDMC4435BZ	MLP 3.3X3.3	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions M	in Typ	Max	Units
Off Chara	ncteristics				
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu\text{A}, V_{GS} = 0 \text{V}$	30		V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, referenced to 25 °C	- 22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -24 V, V _{GS} = 0 V,	TVI	-1 -100	μА
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	MT	±10	μΑ
	cteristics	TW WWW.100Y.CO	M.TW		
$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu\text{A}$ -1	.0 -1.9	-3.0	V

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1.0	-1.9	-3.0	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I _D = -250 μA, referenced to 25 °C	Y.COD	5.3		mV/°C
L CON	THIN OF C	$V_{GS} = -10 \text{ V}, I_D = -8.5 \text{ A}$	V.CU	15	20	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -6.3 \text{ A}$	-7 C	23	37	mΩ
	Static Drain to Source Off Nesistance	$V_{GS} = -10 \text{ V}, I_D = -8.5 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$	00 x .	21	28	11122
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_D = -8.5 \text{ A}$	100 .	24	×1	S
Dynamic	Characteristics	Y.COM.TW WWY	1.100 X	v.COM	TW	,
COMM	Innut Conscitance	115. 24.//	-1110	1510	2045	nE

Dynamic Characteristics

9F5	Terrara Transcentaceanies V _{DD} C V, I _D C.C Y				- N	
Dynam	ic Characteristics					
C _{iss}	Input Capacitance	100 - 050 7	W.100	1540	2045	pF
Coss	Output Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ =f = 1 MHz	WW - 100	295	395	pF
C _{rss}	Reverse Transfer Capacitance	N CONT.	W.	260	385	N pF
$R_{a < 1} $	Gate Resistance	f = 1 MHz	W.1.	5	O_{Mr} ,	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	100 L			10	20	ns
t _r	Rise Time	V_{DD} = -15 V, I_{D} = -8.5 A, V_{GS} = -10 V, R_{GEN} = 6 Ω		MAL	6	12	ns
t _{d(off)}	Turn-Off Delay Time			WW	34	55	ns
t _f	Fall Time				20	36	ns
Q_g	Total Gate Charge	V _{GS} =0V to -10V	VIII	M.	33	46	nC
Q_g	Total Gate Charge	V _{GS} = 0 V to -4.5 V		W	17	24	nC
Q _{gs}	Gate to Source Charge	A. Thomas	$I_D = -8.5 A$		5	×7 (nC
Q _{gd}	Gate to Drain "Miller" Charge	1001.0			9	100 r.	nC

Drain-Source Diode Characteristics

	Comments Bright Binds Essent Valters	$V_{GS} = 0 \text{ V}, I_S = -8.5A$ (Note 2)	0.92	1.5	V. (
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = -1.9 A (Note 2)	0.75	1.2	V
t _{rr}	Reverse Recovery Time	100	22	111 . In	ns
Q _{rr}	Reverse Recovery Charge	I _F = -8.5 A, di/dt = 100 A/μs	11	-11	nC

^{1.} $R_{\theta,JA}$ is determined with the device mounted on a 1 in 2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

- 3. E_{AS} of 24 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = -7 A, V_{DD} = -27 V, V_{GS}= -10 V. 100% test at L = 3 mH, I_{AS} = -4 A.

 4. The diode connected between the gate and source servers only as protection against EGD. WWW.100Y.COM.72

Typical Characteristics T_J = 25°C unless otherwise noted

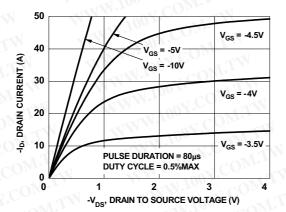


Figure 1. On-Region Characteristics

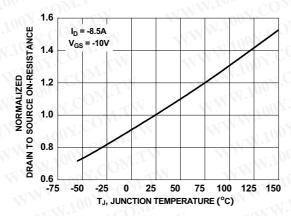


Figure 3. Normalized On-Resistance vs Junction Temperature

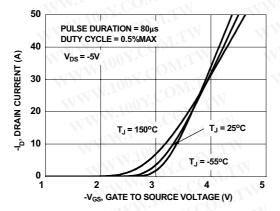


Figure 5. Transfer Characteristics

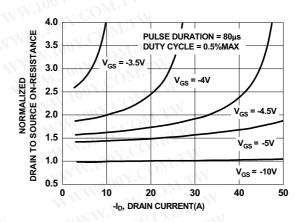


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

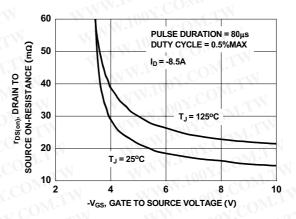


Figure 4. On-Resistance vs Gate to Source Voltage

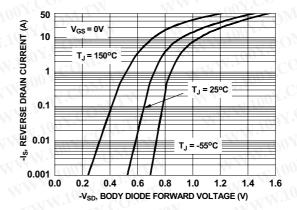


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

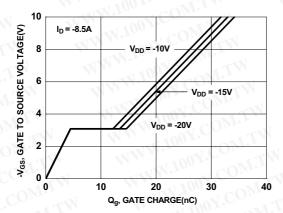


Figure 7. Gate Charge Characteristics

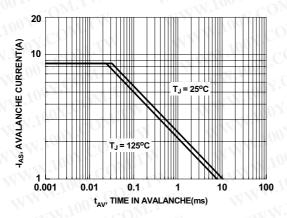


Figure 9. Unclamped Inductive Switching Capability

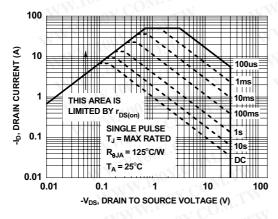


Figure 11. Forward Bias Safe Operating Area

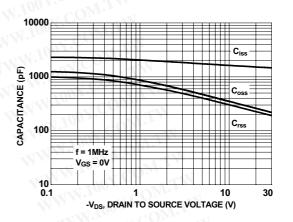


Figure 8. Capacitance vs Drain to Source Voltage

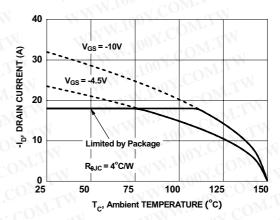


Figure 10. Maximum Continuous Drain Current vs Case Temperature

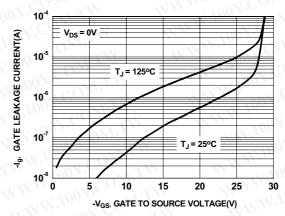
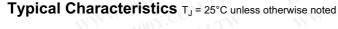


Figure 12. Igss vs Vgss



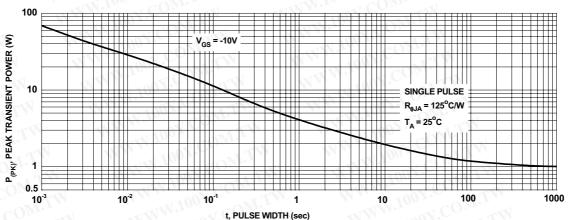


Figure 13. Single Pulse Maximum Power Dissipation

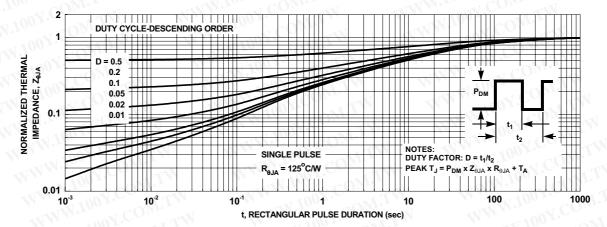
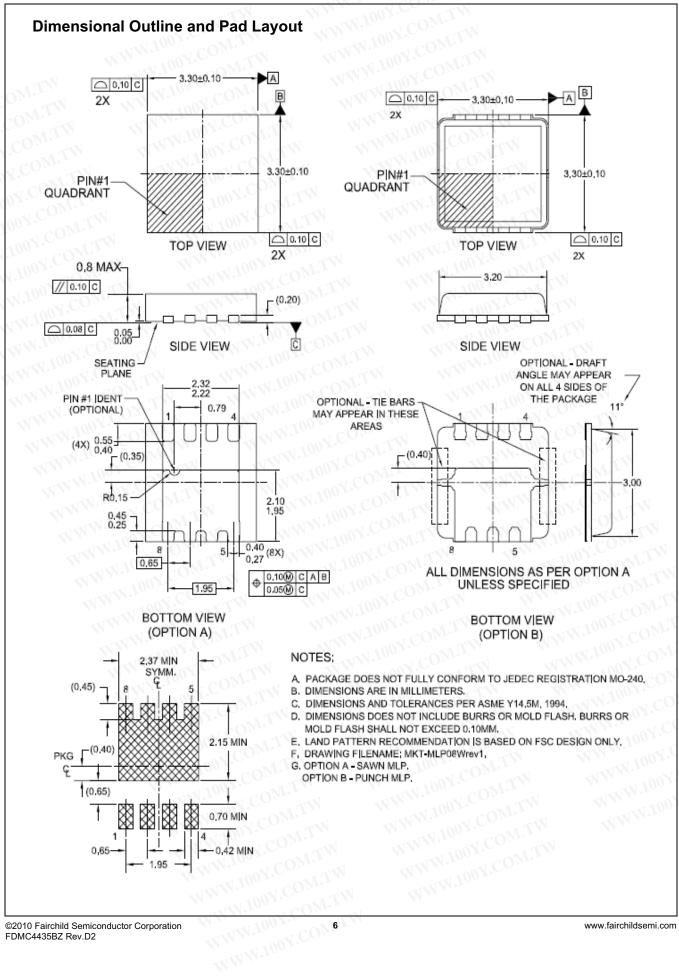


Figure 14. Transient Thermal Response Curve

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